

Notice of References Cited		Application/Control No. 10/598,159	Applicant(s)/Patent Under Reexamination YOON, JI-WON	
		Examiner KATHRIEN CRUZ	Art Unit 1617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,605,296	08-2003	Stuckler, Franz	424/439
	B	US-			
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NON-PATENT DOCUMENTS

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	U	Merck Index (Thirteenth Edition, 2001, pg 1021-1022).
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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